

NATIONAL INSTITUTE OF TECHNOLOGY KURUKSHETRA

Notification for Result of MASTER OF TECHNOLOGY I Semester ,Embedded System Design
examinations
Nov/Dec., 2018

The Result of the following candidates who appeared in MASTER OF TECHNOLOGY I Semester
,Embedded System Design examination of this Institute held in Nov/Dec., 2018 is declared as under:-

Note: SGPA shown means Pass and "R" means Reappear

RL(A) For Result Late (Award)

Sr. No.	Subjects	Code No.
1	Digital IC Design	SVE 501T
2	Hardware Description Languages and FPGA Based Design	SVE 505T
3	Embedded System Fundamentals	SVE 511T
4	Hardware Algorithms for Computer Arithmetic	SVE 519T
5	Embedded System Software Development	SVE 531T
6	Embedded Systems Lab	SVE 537P
7	Seminar	SVE 539P

Sr. No.	Roll No.	Name	F_Name	SGPA
1	31811101	GAURAV KUMAR	PREM KUMAR SINHA	9.3333
2	31811102	ARGHYA BISWAS	ASHOK KUMAR BISWAS	7.8889
3	31811103	ANUPAM KUMAR	BIJENDRA PATHAK	8.6667
4	31811104	GURALA SANDEEP	GURALA SUBBIREDDY	9.2222
5	31811105	K. GARANKUMAR	K CHENCHAIAH	8.7222
6	31811107	AIKENDRAJIT NINGTHOUJAM	NINGTHOUJAM MADHUMANI SINGH	9.1111
7	31811108	PARTHA PRATIM DINDA	KHOKAN DINDA	8.2222
8	31811109	KESHAV MAHATO	VIMAL KUMAR MAHATO	9.0000
9	31811110	AMAN SAXENA	MUKESH SAXENA	8.7222
10	31811111	SHWETA DUBEY	CHANDRA PRAKASH DUBEY	8.3889
11	31811112	RAKSHA KUMARI	RAVINDRA MAAN	9.2778
12	31811113	GUDLA SRIKANTH	GUDLA SRINIVASA RAO	9.6667



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13	31811114	KOVVURU THIRUMANJUNATHA REDDY	K ANJANA REDDY	7.5556
14	31811115	ANAND PRATAP SINGH	ANIL KUMAR SINGH	9.3889
15	31811116	VIJAY SINGH RAWAT	RAMESH SINGH RAWAT	9.0556
16	31811117	GEETANJALI ROHILLA	RAVINDRA KUMAR	9.1667
17	31811118	VIKAS SHARMA	SUSHIL KUMAR	8.3889

**All efforts have been made to publish this result after checking the entries properly.
However, the result can stand revised in case some discrepancy is observed**

Date : 04 JAN 2019
Kurukshetra

Ravi Kant
4-1-19
Prof. In-Charge
(Examinations)
[Signature]